

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/648,367	IIDA, TAKAYUKI	
Examiner		Art Unit		Page 1 of 1
Khai M. Nguyen		2617		

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	E	US-			
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	I	US-			
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	K	US-			
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